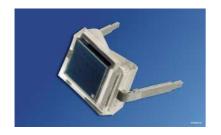
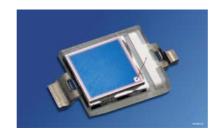
Silizium-PIN-Fotodiode; in SMT und als Reverse Gullwing Silicon PIN Photodiode; in SMT and as Reverse Gullwing Lead (Pb) Free Product - RoHS Compliant BPW 34, BPW 34 S, BPW 34 SR







BPW 34 S BPW 34 SR

Wesentliche Merkmale

- Speziell geeignet f
 ür Anwendungen im Bereich von 400 nm bis 1100 nm
- Kurze Schaltzeit (typ. 20 ns)
- DIL-Plastikbauform mit hoher Packungsdichte
- BPW 34 S/BPW 34 SR: geeignet für Reflow Löten

Anwendungen

- Lichtschranken für Gleich- und Wechsellichtbetrieb
- IR-Fernsteuerungen
- Industrieelektronik
- "Messen/Steuern/Regeln"

Features

- Especially suitable for applications from 400 nm to 1100 nm
- Short switching time (typ. 20 ns)
- DIL plastic package with high packing density
- BPW 34 S/BPW 34 SR: suitable for reflow soldering

Applications

- Photointerrupters
- IR remote controls
- Industrial electronics
- · For control and drive circuits

Тур Туре	Bestellnummer Ordering Code	Fotostrom, E_v =1000 lx, standard light A, V_R = 5 V Photocurrent lp (μ A)
BPW 34	Q62702P0073	80 (≥50)
BPW 34 S	Q65110A1209	80 (≥50)
BPW 34 SR	Q65110A2701	80 (≥50)

2007-05-23

Grenzwerte Maximum Ratings

Bezeichnung Parameter	Symbol Symbol	Wert Value	Einheit Unit
Betriebs- und Lagertemperatur Operating and storage temperature range	$T_{\rm op};T_{\rm stg}$	- 40 + 100	°C
Sperrspannung Reverse voltage	V_{R}	32	V
Verlustleistung, $T_{\rm A}$ = 25 ° C Total power dissipation	P_{tot}	150	mW

Kennwerte ($T_{\rm A}$ = 25 ° C, Normlicht A, T = 2856 K) Characteristics ($T_{\rm A}$ = 25 ° C, standard light A, T = 2856 K)

Bezeichnung Parameter	Symbol Symbol	Wert Value	Einheit Unit
Fotoempfindlichkeit, $V_{\rm R}$ = 5 V Spectral sensitivity	S	80 (≥50)	nA/Ix
Wellenlänge der max. Fotoempfindlichkeit Wavelength of max. sensitivity	$\lambda_{\text{S max}}$	850	nm
Spektraler Bereich der Fotoempfindlichkeit $S = 10\%$ von $S_{\rm max}$ Spectral range of sensitivity $S = 10\%$ of $S_{\rm max}$	λ	400 1100	nm
Bestrahlungsempfindliche Fläche Radiant sensitive area	A	7.00	mm ²
Abmessung der bestrahlungsempfindlichen Fläche Dimensions of radiant sensitive area	$L \times B$ $L \times W$	2.65 × 2.65	mm× mm
Halbwinkel Half angle	φ	±60	Grad deg.
Dunkelstrom, $V_{\rm R}$ = 10 V Dark current	I_{R}	2 (≤30)	nA
Spektrale Fotoempfindlichkeit, λ = 850 nm Spectral sensitivity	S_{λ}	0.62	A/W
Quantenausbeute, λ = 850 nm Quantum yield	η	0.90	Electrons Photon
Leerlaufspannung, $E_{\rm v}$ = 1000 lx Open-circuit voltage	V_{O}	365 (≥ 300)	mV



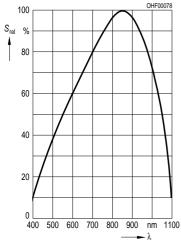
Kennwerte ($T_{\rm A}$ = 25 ° C, Normlicht A, T = 2856 K) Characteristics ($T_{\rm A}$ = 25 ° C, standard light A, T = 2856 K) (cont'd)

Bezeichnung Parameter	Symbol Symbol	Wert Value	Einheit Unit
Kurzschlussstrom, $E_{\rm v}$ = 1000 lx Short-circuit current	I_{SC}	80	μΑ
Anstiegs- und Abfallzeit des Fotostromes Rise and fall time of the photocurrent $R_{\rm L}$ = 50 Ω ; $V_{\rm R}$ = 5 V; λ = 850 nm; $I_{\rm p}$ = 800 μ A	$t_{\rm r},t_{\rm f}$	20	ns
Durchlassspannung, $I_{\rm F}$ = 100 mA, E = 0 Forward voltage	V_{F}	1.3	V
Kapazität, $V_{\rm R}$ = 0 V, f = 1 MHz, E = 0 Capacitance	C_0	72	pF
Temperaturkoeffizient von $V_{\rm O}$ Temperature coefficient of $V_{\rm O}$	TC_{V}	- 2.6	mV/K
Temperaturkoeffizient von I_{SC} Temperature coefficient of I_{SC}	TC_1	0.18	%/K
Rauschäquivalente Strahlungsleistung Noise equivalent power $V_{\rm R}$ = 10 V, λ = 850 nm	NEP	4.1 × 10 ⁻¹⁴	$\frac{W}{\sqrt{Hz}}$
Nachweisgrenze, $V_{\rm R}$ = 10 V, λ = 850 nm Detection limit	D*	6.6 × 10 ¹²	$\frac{\text{cm} \times \sqrt{\text{Hz}}}{\text{W}}$

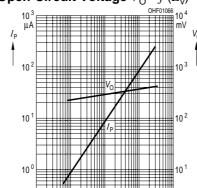


Relative Spectral Sensitivity



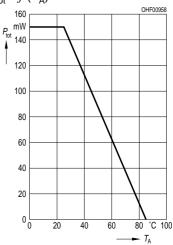


Photocurrent $I_{\rm P}$ = f ($E_{\rm V}$), $V_{\rm R}$ = 5 V Open-Circuit Voltage $V_{\rm O}$ = f ($E_{\rm V}$)



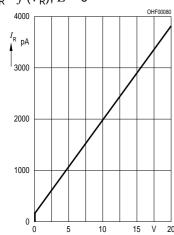
Total Power Dissipation

 $P_{\text{tot}} = f(T_{A})$



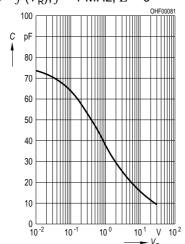
Dark Current

$$I_{\mathsf{R}} = f(V_{\mathsf{R}}), E = 0$$

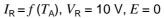


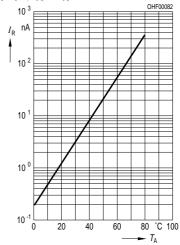
Capacitance

$$C = f(V_R), f = 1 \text{ MHz}, E = 0$$



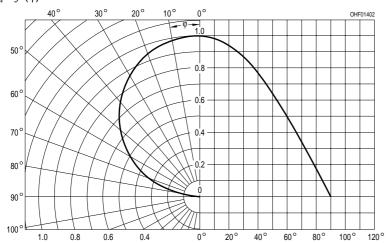
Dark Current



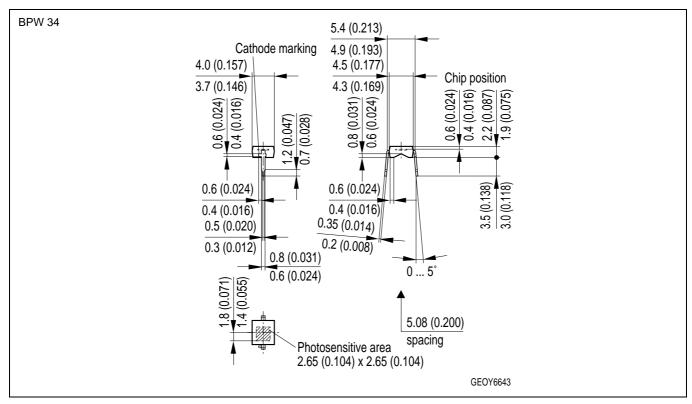


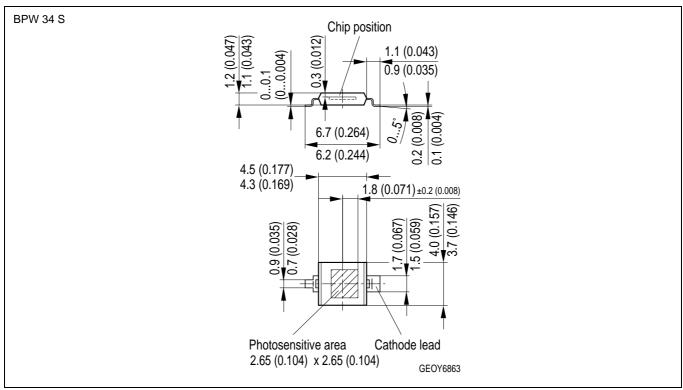
Directional Characteristics

$$S_{\text{rel}} = f(\varphi)$$



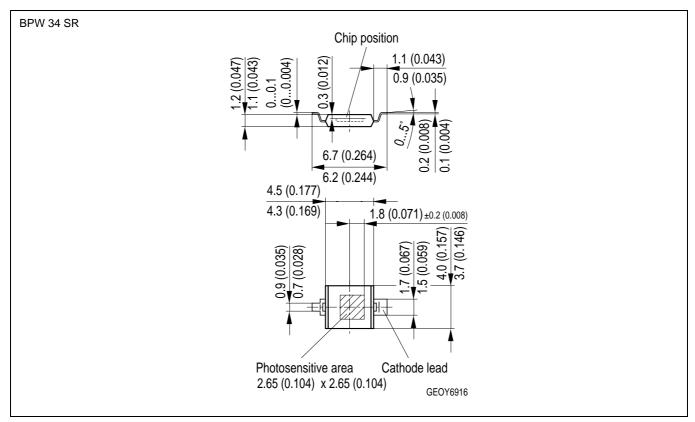
Maßzeichnung Package Outlines





Maße in mm (inch) / Dimensions in mm (inch).



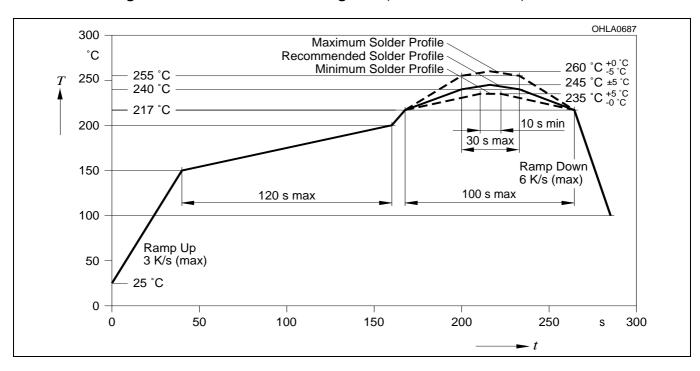


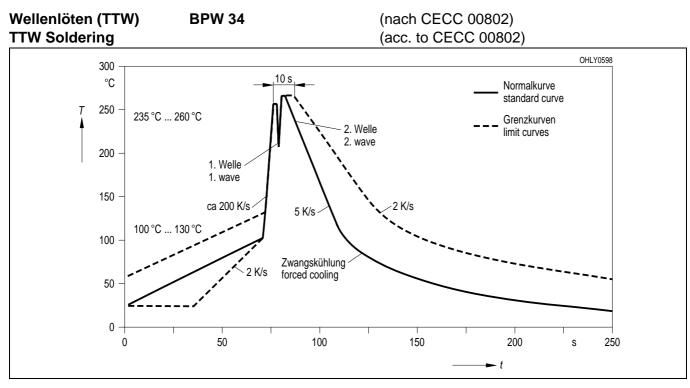
Maße in mm (inch) / Dimensions in mm (inch).



Lötbedingungen BPW 34 S Soldering Conditions BPW 34 SR Vorbehandlung nach JEDEC Level 4 Preconditioning acc. to JEDEC Level 4

Reflow Lötprofil für bleifreies Löten Reflow Soldering Profile for lead free soldering (nach J-STD-020C) (acc. to J-STD-020C)





Published by OSRAM Opto Semiconductors GmbH Wernerwerkstrasse 2, D-93049 Regensburg

www.osram-os.com

© All Rights Reserved.

EU RoHS and China RoHS compliant product



此产品符合欧盟 RoHS 指令的要求;

按照中国的相关法规和标准,不含有毒有害物质或元素。

The information describes the type of component and shall not be considered as assured characteristics. Terms of delivery and rights to change design reserved. Due to technical requirements components may contain dangerous substances. For information on the types in question please contact our Sales Organization.

Packing

Please use the recycling operators known to you. We can also help you – get in touch with your nearest sales office. By agreement we will take packing material back, if it is sorted. You must bear the costs of transport. For packing material that is returned to us unsorted or which we are not obliged to accept, we shall have to invoice you for any costs incurred.

Components used in life-support devices or systems must be expressly authorized for such purpose! Critical components ¹, may only be used in life-support devices or systems ² with the express written approval of OSRAM OS. ¹ A critical component is a component used in a life-support device or system whose failure can reasonably be expected to cause the failure of that life-support device or system, or to affect its safety or effectiveness of that device or system.

² Life support devices or systems are intended (a) to be implanted in the human body, or (b) to support and/or maintain and sustain human life. If they fail, it is reasonable to assume that the health of the user may be endangered.

2007-05-23

